AT-42010

Up to 6 GHz Medium Power Silicon Bipolar Transistor

Data Sheet

Description

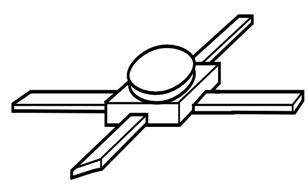
Avago's AT-42010 is a general purpose NPN bipolar transistor that offers excellent high frequency performance. The AT-42010 is housed in a hermetic, high reliability 100 mil ceramic package. The 4 micron emitter-to-emitter pitch enables this transistor to be used in many different functions. The 20 emitter finger interdigitated geometry yields a medium sized transistor with impedances that are easy to match for low noise and medium power applications. This device is designed for use in low noise, wideband amplifier, mixer and oscillator applications in the VHF, UHF, and microwave frequencies. An optimum noise match near 50Ω up to 1 GHz, makes this device easy to use as a low noise amplifier.

The AT-42010 bipolar transistor is fabricated using Avago's 10 GHz fT Self-Aligned-Transistor (SAT) process. The die is nitride passivated for surface protection. Excellent device uniformity, performance and reliability are produced by the use of ion-implantation, self-alignment techniques, and gold metalization in the fabrication of this device.

Features

- High Output Power:
  21.0 dBm Typical $P_{1\ dB}$ at 2.0 GHz
  20.5 dBm Typical $P_{1\ dB}$ at 4.0 GHz
- High Gain at 1 dB Compression:
  14.0 dB Typical $G_{1\ dB}$ at 2.0 GHz
  9.5 dB Typical $G_{1\ dB}$ at 4.0 GHz
- Low Noise Figure:
  1.9 dB Typical NF_O at 2.0 GHz
- High Gain-Bandwidth Product: 8.0 GHz Typical f_T
- Hermetic Gold-ceramic Microstrip Package

100 mil Package



AT-42010 Absolute Maximum Ratings[1]

Symbol	Parameter	Units	Absolute Maximum
V_{EBO}	Emitter-Base Voltage	V	1.5
V_{CBO}	Collector-Base Voltage	V	20
V_{CEO}	Collector-Emitter Voltage	V	12
I_C	Collector Current	mA	80
P_T	Power Dissipation [2,3]	mW	600
T_j	Junction Temperature	°C	200
T_{STG}	Storage Temperature	°C	-65 to 200

Thermal Resistance [2,4]:

$\theta_{jc} = 150°C/W$

Notes:
1. Permanent damage may occur if any of these limits are exceeded.
2. Tcase = 25°C.
3. Derate at 6.7 mW/°C for Tc > 110°C.
4. The small spot size of this technique results in a higher, though more accurate determination of θjc than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications, $T_A = 25°C$

Symbol	Parameters and Test Conditions[1]		Units	Min.	Typ.	Max.
$\|S_{21E}\|^2$	Insertion Power Gain; $V_{CE} = 8$ V, $I_C = 35$ mA	f = 2.0 GHz	dB	10.5	11.5	
		f = 4.0 GHz		5.5		
$P_{1 dB}$	Power Output @ 1 dB Gain Compression	f = 2.0 GHz	dBm		21.0	
	$V_{CE} = 8$ V, $I_C = 35$ mA	f= 4.0 GHz		20.5		
$G_{1 dB}$	1 dB Compressed Gain; $V_{CE} = 8$ V, $I_C = 35$ mA	f = 2.0 GHz	dB		14.0	
		f = 4.0 GHz		9.5		
NF_O	Optimum Noise Figure: $V_{CE} = 8$ V, $I_C = 10$ mA	f = 2.0 GHz	dB		1.9	
		f = 4.0 GHz		3.0		
G_A	Gain @ NF_O; $V_{CE} = 8$ V, $I_C = 10$ mA	f = 2.0 GHz	dB		13.5	
		f = 4.0 GHz		10.0		
f_T	Gain Bandwidth Product: $V_{CE} = 8$ V, $I_C = 35$ mA		GHz		8.0	
h_{FE}	Forward Current Transfer Ratio; $V_{CE} = 8$ V, $I_C = 35$ mA		—	30	150	270
I_{CBO}	Collector Cutoff Current; $V_{CB} = 8$ V		μA			0.2
I_{EBO}	Emitter Cutoff Current; $V_{EB} = 1$ V		μA			2.0
C_{CB}	Collector Base Capacitance[1]: $V_{CB} = 8$ V, f = 1 MHz		pF		0.28	

Notes:
1. For this test, the emitter is grounded.

AT-42010 Typical Performance, $T_A = 25°C$

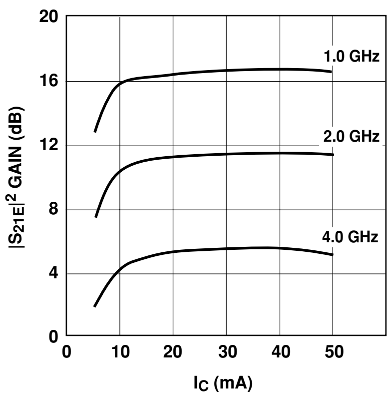


Figure 1. Insertion Power Gain vs. Collector Current and Frequency. $V_{CE} = 8$ V.

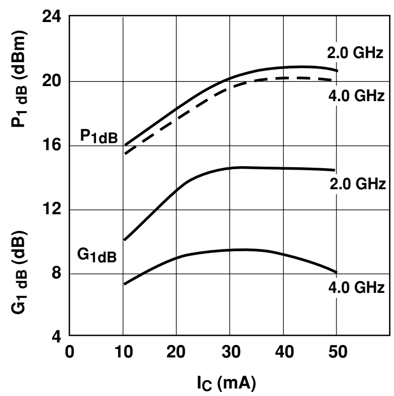


Figure 2. Output Power and 1 dB Compressed Gain vs. Collector Current and Frequency. $V_{CE} = 8$ V.

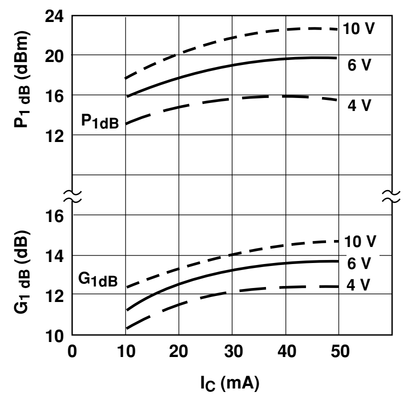


Figure 3. Output Power and 1 dB Compressed Gain vs. Collector Current and Voltage. f = 2.0 GHz.

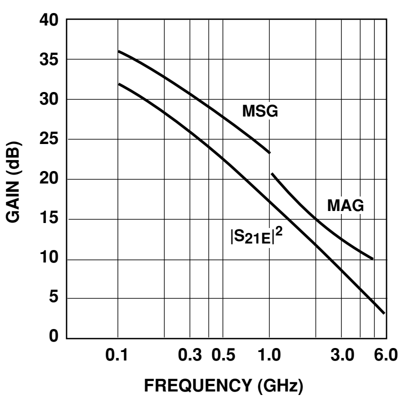


Figure 4. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency. $V_{CE} = 8$ V, $I_C = 35$ mA.

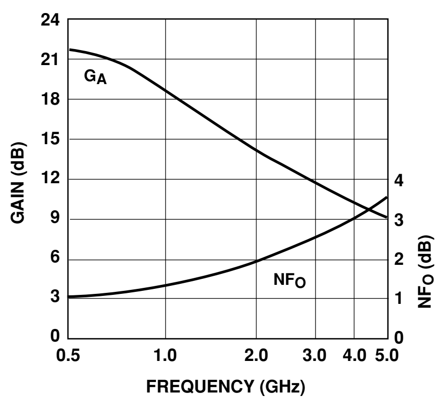


Figure 5. Noise Figure and Associated Gain vs. Frequency. $V_{CE} = 8$ V, $I_C = 10$ mA.

AT-42010 Typical Scattering Parameters,
Common Emitter, Z_0 = 50 Ω, T_A = 25°C, V_{CE} = 8 V, I_C = 10 mA

Freq.	S_{11}		S_{21}			S_{12}			S_{22}	
GHz	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.
0.1	.74	-47	28.5	26.65	153	-36.4	.015	72	.91	-18
0.5	.65	-136	21.4	11.71	103	-29.4	.034	38	.51	-39
1.0	.63	-168	15.9	6.24	82	-27.2	.044	36	.40	-42
1.5	.63	174	12.6	4.26	69	-26.0	.050	42	.38	-45
2.0	.63	161	10.1	3.23	57	-24.6	.059	43	.38	-49
2.5	.64	154	8.4	2.64	51	-23.0	.070	52	.38	-51
3.0	.65	145	6.9	2.22	41	-22.0	.080	54	.37	-56
3.5	.66	136	5.8	1.94	31	-21.0	.090	51	.38	-65
4.0	.66	126	4.7	1.72	21	-19.7	.104	50	.39	-74
4.5	.66	115	3.8	1.55	11	-18.0	.126	45	.40	-82
5.0	.66	103	3.0	1.41	1	-17.3	.136	41	.40	-89
5.5	.68	90	2.1	1.28	-9	-16.1	.156	36	.40	-98
6.0	.72	81	1.3	1.16	-19	-15.4	.170	31	.37	-110

AT-42010 Typical Scattering Parameters,
Common Emitter, Z_0 = 50 Ω, T_A = 25°C, V_{CE} = 8 V, I_C = 35 mA

Freq.	S_{11}		S_{21}			S_{12}			S_{22}	
GHz	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.
0.1	.54	-90	33.3	45.97	138	-39.2	.011	54	.76	-29
0.5	.62	-163	22.8	13.83	94	-33.2	.022	52	.34	-40
1.0	.62	177	17.0	7.10	78	-28.8	.036	59	.30	-40
1.5	.62	166	13.6	4.82	67	-26.2	.049	61	.29	-42
2.0	.62	155	11.3	3.65	56	-23.8	.065	57	.29	-47
2.5	.63	150	9.5	2.99	51	-21.8	.081	62	.29	-50
3.0	.64	142	8.0	2.52	42	-21.0	.090	63	.30	-57
3.5	.65	133	6.8	2.19	32	-19.7	.103	59	.30	-67
4.0	.65	124	5.7	1.93	22	-18.4	.120	54	.31	-76
4.5	.65	113	4.7	1.72	13	-17.2	.138	49	.33	-85
5.0	.66	102	3.9	1.56	3	-16.6	.148	45	.34	-92
5.5	.69	91	3.0	1.41	-6	-15.6	.166	39	.33	-100
6.0	.73	83	2.1	1.27	-16	-14.9	.180	32	.30	-110

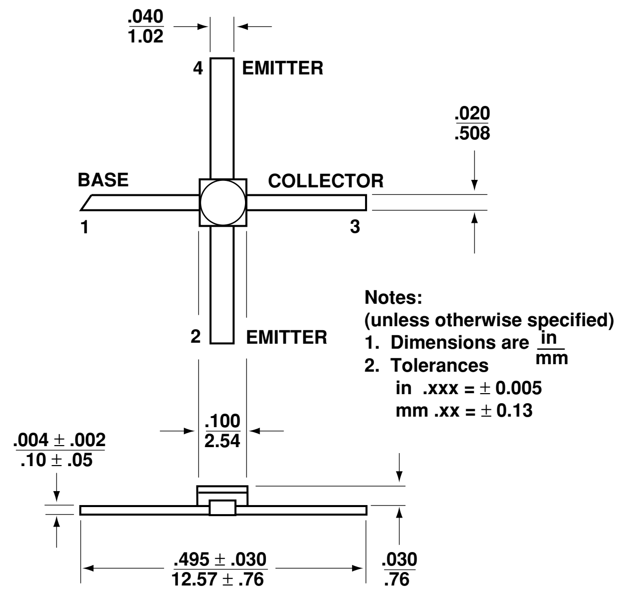
AT-42010 Noise Parameters: V_{CE} = 8 V, I_C = 10 mA

Freq. GHz	NF_O dB	Γ_{opt}		$R_N/50$
		Mag	Ang	
0.1	1.0	.04	15	0.13
0.5	1.1	.05	76	0.12
1.0	1.5	.10	132	0.12
2.0	1.9	.23	-177	0.11
4.0	3.0	.45	-125	0.26

Ordering Information

Part Number	No. of Devices
AT-42010	100

100 mil Package Dimensions



For product information and a complete list of distributors, please go to our web site: **www.avagotech.com**

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